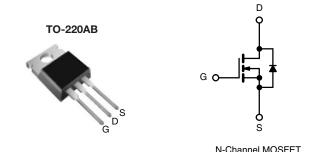


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	50	500			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.85			
Q _g (Max.) (nC)	6	63			
Q _{gs} (nC)	9.	9.3			
Q _{gd} (nC)	3	32			
Configuration	Sin	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Load (Dh) froe	IRF840PbF
Lead (Pb)-free	SiHF840-E3
SnPb	IRF840
SIFD	SiHF840

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V -140V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		8.0		
	V _{GS} at 10 V	T _C = 100 °C	I _D	5.1	A	
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	510	mJ	
Repetitive Avalanche Current ^a			I _{AR}	8.0	А	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 14 mH, R_g = 25 Ω , I_{AS} = 8.0 A (see fig. 12).
- c. $I_{SD} \le 8.0$ A, $dI/dt \le 100$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0	

PARAMETER	SYMBOL	TEST (CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$) V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.78	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	VG	_{SS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} = 5	V _{DS} = 500 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V, V	V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 4.8 A^b$	-	-	0.85	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 50 \text{ V}, I_D = 4.8 \text{ A}^b \qquad \qquad 4.9 \qquad - \qquad - \qquad S$ $V_{GS} = 0 \text{ V}, \qquad \qquad - \qquad 1300 \qquad - \qquad \\ V_{DS} = 25 \text{ V}, \qquad \qquad - \qquad 310 \qquad - \qquad pF$ $f = 1.0 \text{ MHz}, \text{ see fig. 5} \qquad \qquad - \qquad - \qquad 63$		S			
Dynamic							
Input Capacitance	C _{iss}	V	$V_{GS} = 0 V$,		1300	-	
Output Capacitance	C _{oss}	V	_{DS} = 25 V,	1	310	-	pF
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		1	120	-	
Total Gate Charge	Q_g			-	-	63	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 8 \text{ A}, V_{DS} = 400 \text{ V},$	-	-	9.3	nC
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b	-	-	32	
Turn-On Delay Time	t _{d(on)}		•	-	14	-	
Rise Time	t _r	$V_{DD} = 250 \text{ V}, I_{D} = 8 \text{ A}$ $R_{g} = 9.1 \Omega, R_{D} = 31 \Omega, \text{ see fig. } 10^{b}$		-	23	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	49	-	
Fall Time	t _f]		-	20	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbo showing the	MOSFET symbol showing the		-	8.0	A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction did	ode	-	-	32	^
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$I_S = 8 A, V_{GS} = 0 V^b$	ı	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 8 A, dl/dt = 100 A/μs ^b		-	460	970	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	4.2	8.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on time is negligible (turn	on is do	minated b	by L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

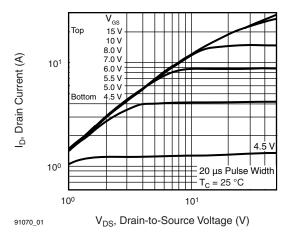


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

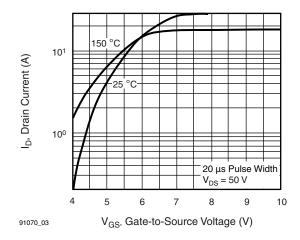


Fig. 3 - Typical Transfer Characteristics

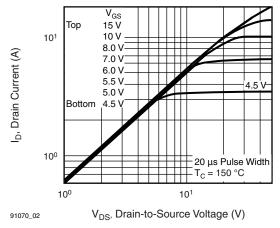


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

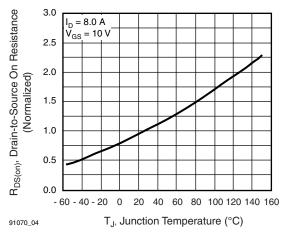


Fig. 4 - Normalized On-Resistance vs. Temperature



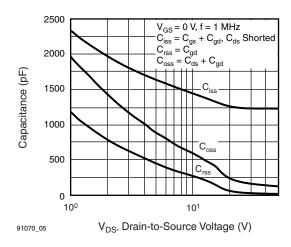


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

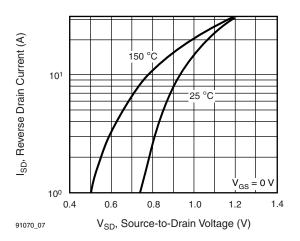


Fig. 7 - Typical Source-Drain Diode Forward Voltage

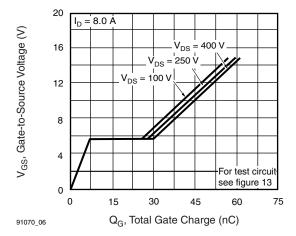


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage

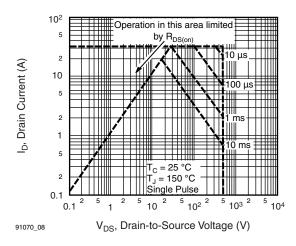


Fig. 8 - Maximum Safe Operating Area





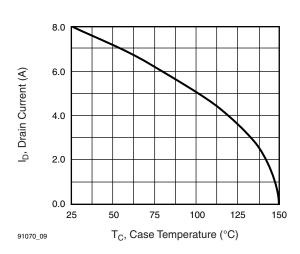


Fig. 9 - Maximum Drain Current vs. Case Temperature

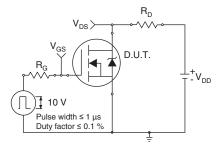


Fig. 10a - Switching Time Test Circuit

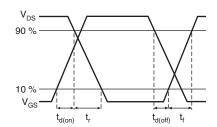


Fig. 10b - Switching Time Waveforms

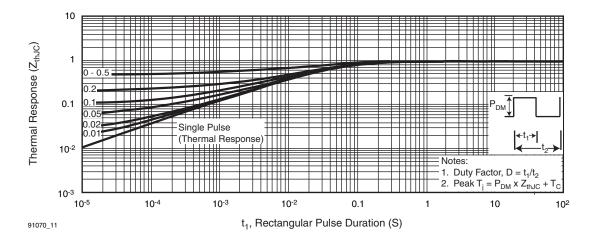


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



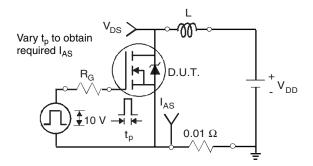


Fig. 12a - Unclamped Inductive Test Circuit

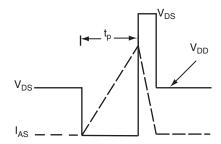


Fig. 12b - Unclamped Inductive Waveforms

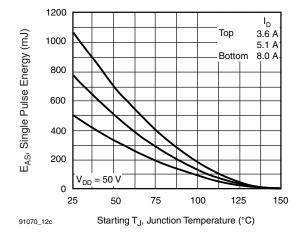


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

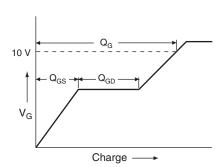


Fig. 13a - Basic Gate Charge Waveform

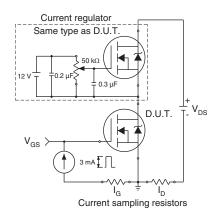
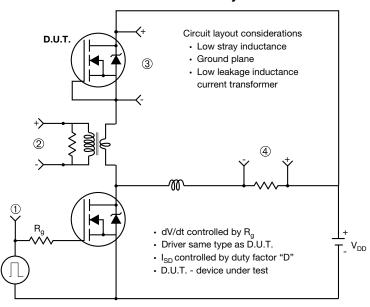


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



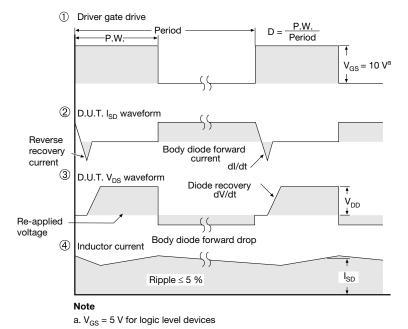


Fig. 14 - For N-Channel

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TO-220-1



DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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